



# Chip to Module and Direct Attach Cable Channel Analysis

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EVERY CONNECTION COUNTS



# Objective: Provide Further Analysis on Chip to Module and Direct Attach Cable Channels

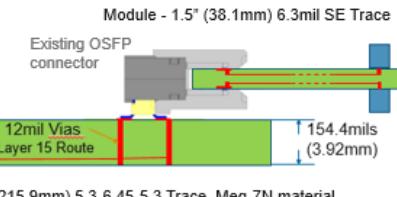
- At the September Interim meeting *tracy\_3ck\_01a\_0918.pdf* provided 12dB and 15dB host board channel analysis
- This presentation provides the requested analysis for a 16dB host board channel (chip to module), and provides analysis of a direct attach cable (DAC) channel and considers the DAC with a host channel.
- 100  $\Omega$  and 90  $\Omega$  trace impedances are also considered.

# Review of tracy\_3ck\_01a\_0918

## Channel Details (from tracy\_100GEL\_01a\_0118)

### Host layer stack-up

Cu Weight  
0.5 STD  
0.5 HVP L02 SIGNAL  
0.5 HVP  
0.5  
0.5  
0.5  
0.5  
0.5  
0.5  
0.5  
0.5 HVP L15 SIGNAL  
0.5 STD  
Total Thickness = 154.4mils



Module - 1.5" (38.1mm) 6.3mil SE Trace  
Existing OSFP connector  
12mil Vias  
Layer 15 Route  
154.4mils (3.92mm)  
Host - 8.5" (215.9mm) 5.3-6.45-5.3 Trace, Meg-7N material

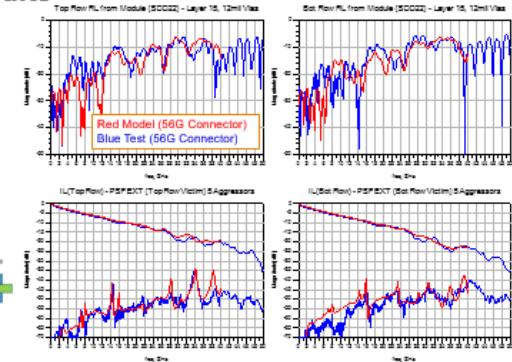
## Test vs Model Results



Existing OSFP connector  
Module - 1.5" (38.1mm) 6.3mil SE Trace  
12mil Vias  
Layer 15 Route  
154.4mils (3.92mm)  
Host - 8.5" (215.9mm) 5.3-6.45-5.3 Trace, Meg-7N material

Note: Measured channel includes second set of via to test point, modeled channels do not include the second set of via.

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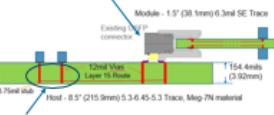


TE

## 100G Connector Improvements (in the same 15dB channel)

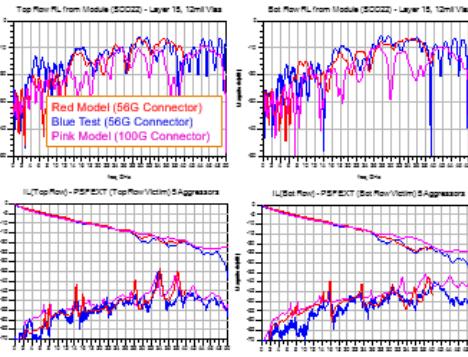
Efforts were focused on insertion loss and return loss optimizations

Improved 100Gbps OSFP connector



Existing OSFP connector  
Module - 1.5" (38.1mm) 6.3mil SE Trace  
12mil Vias  
Layer 15 Route  
154.4mils (3.92mm)  
Host - 8.5" (215.9mm) 5.3-6.45-5.3 Trace, Meg-7N material

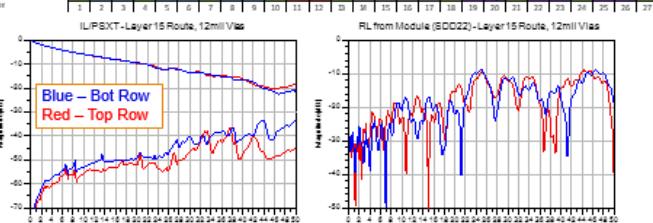
Note: Measured channel includes second set of via to test point, modeled channels do not include the second set of via.



TE

## Improved Connector in a 12dB Channel – Layer 15 Route-out

Victim  
Bot Row  
FEXT Aggressor  
NEXT Aggressor  
Top Row  
Victim



Victim  
FEXT Aggressor  
NEXT Aggressor  
Top Row  
Victim



## COM v2.41 – Improved OSFP Connector in 12/15dB Channel

15 Crosstalk Aggressors – 8 NEXT AND 7 FEXT  
Maximum Frequency = 50 GHz – 10MHz Step

COM script 2.41  
(FFE: 2 pre-cursor + 4 post cursor)

PAM-4 [IEEE802.3ck]		
COM*	Case 1	Case 2
15dB	2.68	3.89
12dB	2.71	4.1

New C2M configuration file:  
[ghiasi\\_3ck\\_adhoc\\_01a\\_082918.pdf](#)

COM script 2.41  
(FFE: 0 pre-cursor + 4 post cursor)

PAM-4 [IEEE802.3ck]		
COM*	Case 1	Case 2
15dB	4.09	4.71
12dB	4.20	4.89

- COM script version 2.41 (com\_ieee8023\_93a\_241a.m)
- Configuration settings (T1/config\_com\_ieee8023\_93a=100GEL\_C2M\_tp0\_tp2\_nFFE7)
- COM > 3dB PASSES
- COM Test Case 1 and Test Case 2 differ in the value of the device package transmission line length  $z_p$  = 12mm and 30mm respectively

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## COM v2.41 – Improved OSFP Connector in 12/15dB Channel

15 Crosstalk Aggressors – 8 NEXT AND 7 FEXT  
Maximum Frequency = 50 GHz – 10MHz Step

COM script 2.41 (FFE: 2pot cursor + 6 post cursor + DFE 16 taps)

PAM-4 [IEEE802.3ck]		
COM	Case 1	Case 2
15dB	5.93	5.16
12dB	6.24	5.45

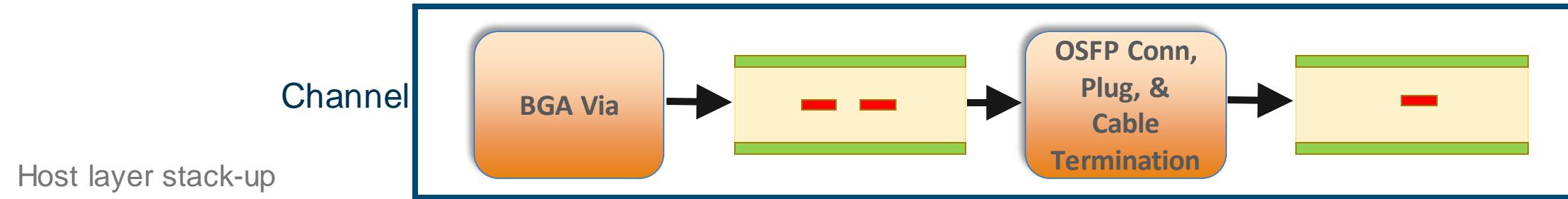
- COM script version 2.41 (com\_ieee8023\_93a\_241a.m)
- COM > 3dB PASSES
- COM Test Case 1 and Test Case 2 differ in the value of the device package transmission line length  $z_p$  = 12mm and 30mm respectively

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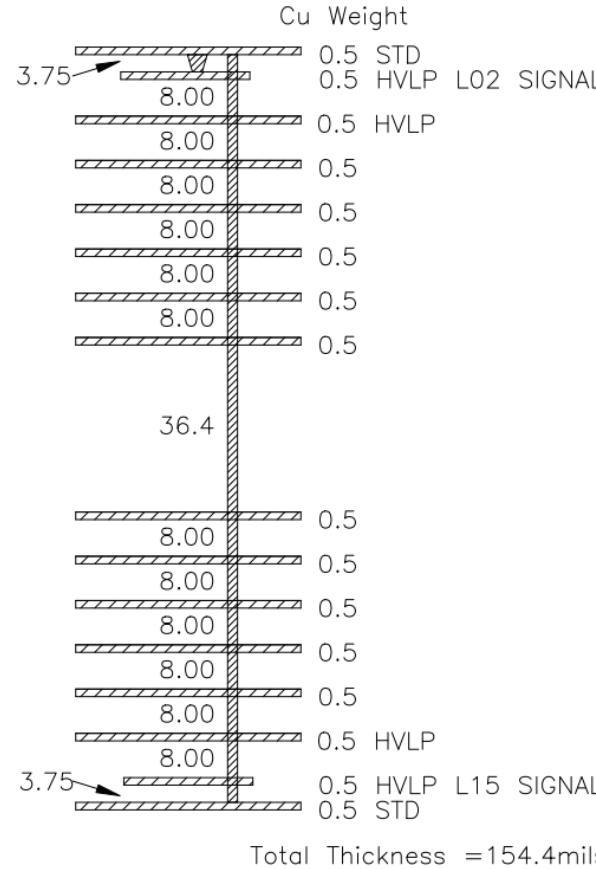
September meeting requested that a 16 dB channel be included

# Chip to Module Channel (C2M) Simulation

# New Analysis: 16dB Chip to Module Channel Created

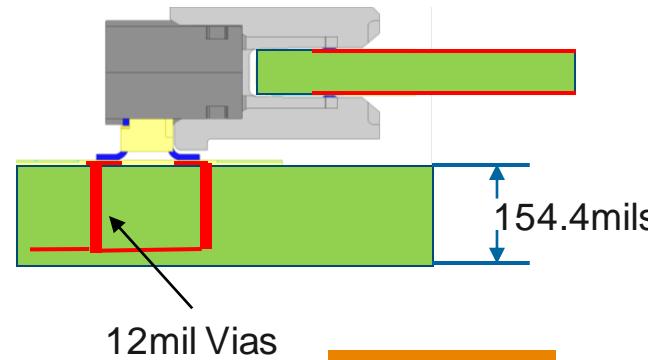
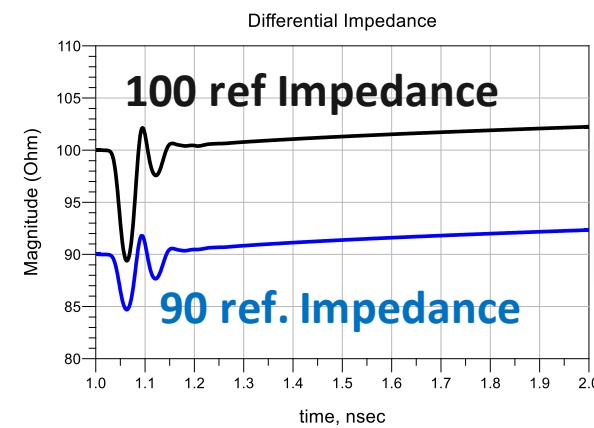


Host layer stack-up

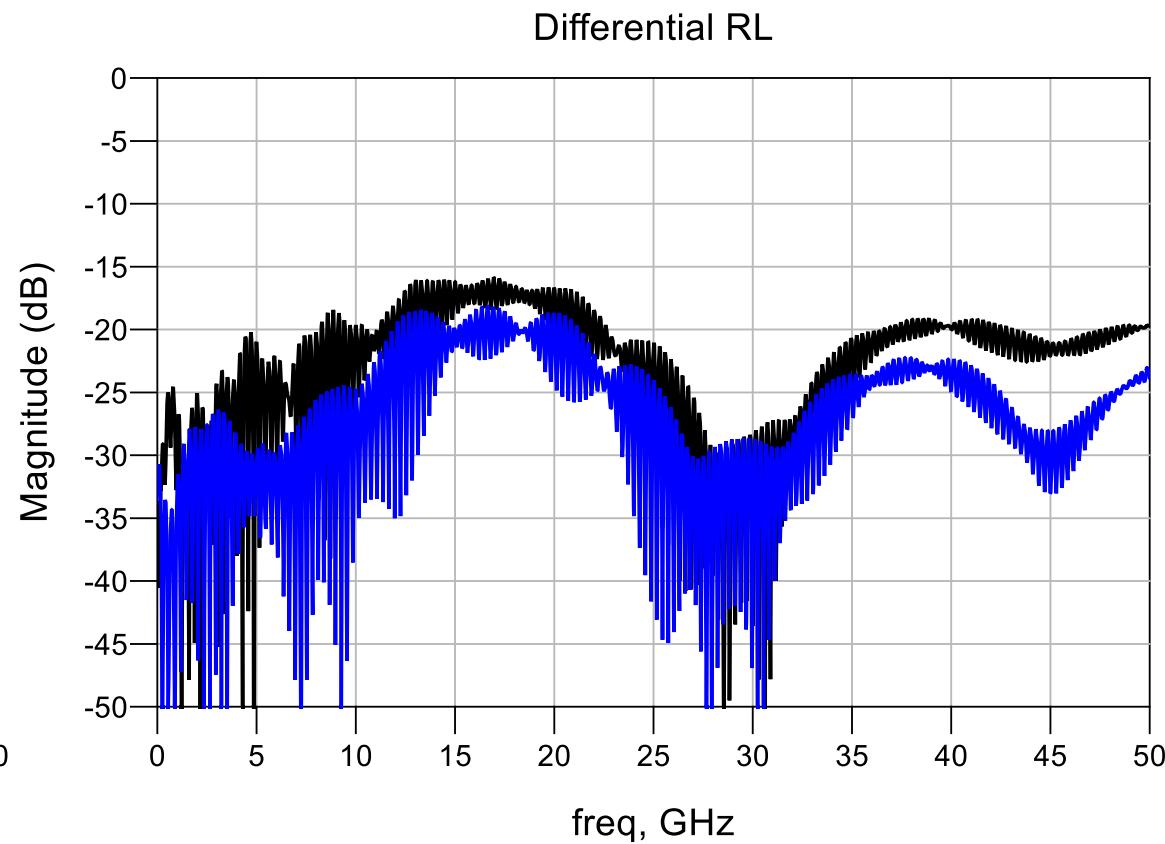
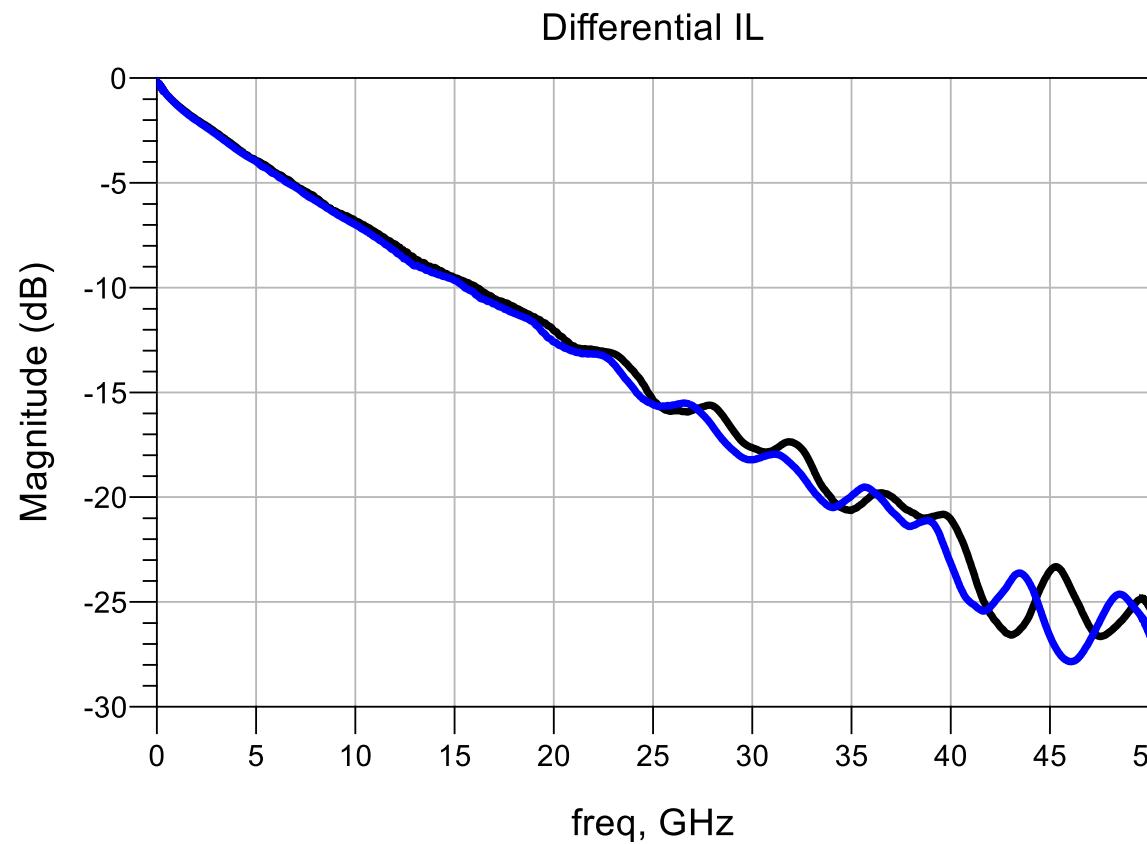


Ref $\Omega$	Host Loss @ 26.56GHz
100 ref $\Omega$	-12.34
90 ref $\Omega$	-12.78

Ref $\Omega$	Module Loss @ 26.56GHz
100 ref $\Omega$	-1.514
90 ref $\Omega$	-1.465



# 16dB C2M Channel: 100 and 90 ref. impedance comparison



# COM v2.41 – C2M OSFP Connector in 16dB Channel

15 Crosstalk Aggressors – 8 NEXT AND 7 FEXT  
Maximum Frequency = 50 GHz – 10MHz Step

COM script 2.41  
(FFE: 2 pre-cursor + 4 post cursor + 1 DFE)

	PAM-4 [IEEE802.3ck]	
COM*	Case 1	Case 2
<b>100 ohm 16dB</b>	<b>3.96</b>	<b>4.78</b>
<b>90 ohm 16dB</b>	<b>3.61</b>	<b>4.46</b>

- COM script version 2.41 (com\_ieee8023\_93a\_241a.m)
- Configuration settings (T1config\_com\_ieee8023\_93a=100GEL\_C2M\_tp0\_tp2\_rxFFE7) – adjusted to include 1 DFE
- COM > 3dB PASSES
- COM Test Case 1 and Test Case 2 differ in the value of the device package transmission line length  $z_p$  - 12mm and 30mm respectively

# COM v2.41 – C2M OSFP Connector in 12/15/16dB Channel

15 Crosstalk Aggressors – 8 NEXT AND 7 FEXT  
Maximum Frequency = 50 GHz – 10MHz Step

COM script 2.41  
(FFE: 2 pre-cursor + 4 post cursor + 1 DFE)

PAM-4 [IEEE802.3ck]		
COM*	Case 1	Case 2
<b>100 ohm 16dB</b>	<b>3.96</b>	<b>4.78</b>
<b>100 ohm 15dB</b>	<b>3.81</b>	<b>4.86</b>
<b>100 ohm 12dB</b>	<b>4.08</b>	<b>4.91</b>

- COM script version 2.41 (com\_ieee8023\_93a\_241a.m)
- Configuration settings (T1config\_com\_ieee8023\_93a=100GEL\_C2M\_tp0\_tp2\_rxFFE7) – adjusted to include 1 DFE
- COM > 3dB PASSES
- COM Test Case 1 and Test Case 2 differ in the value of the device package transmission line length  $z_p$  - 12mm and 30mm respectively

# Cable Assembly Channel (CR) Simulation

# 17.6dB Cable assembly (TP1-TP4) - description

-2.3@26.56GHz – 100 ref. Impedance

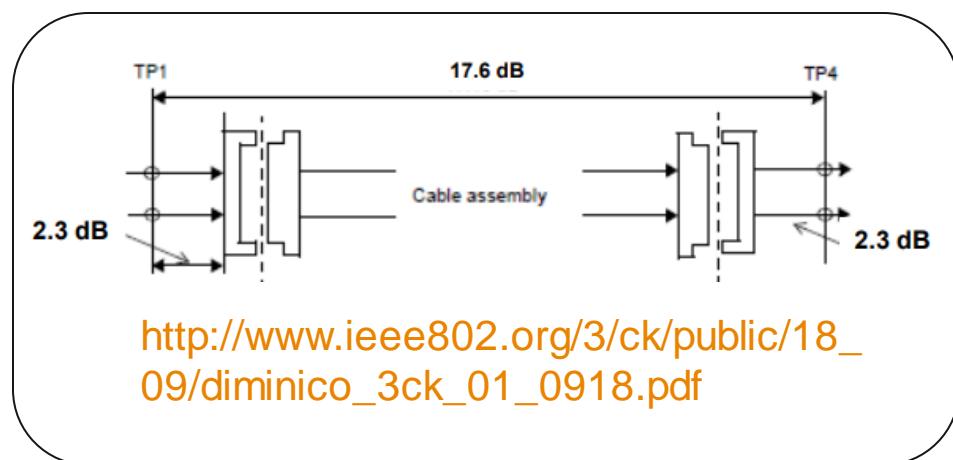
-2.3@26.56GHz – 90 ref. Impedance

-2.3@26.56GHz – 100 ref. Impedance

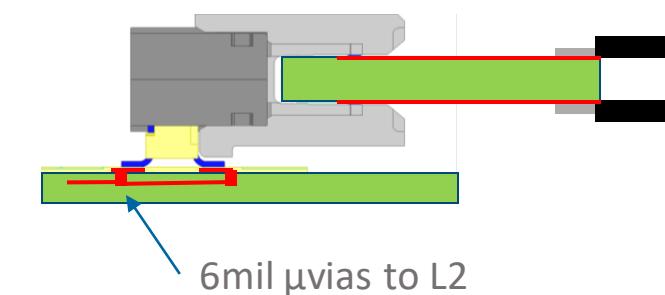
-2.3@26.56GHz – 90 ref. Impedance



## Cable assembly and Channel IL - Baseline

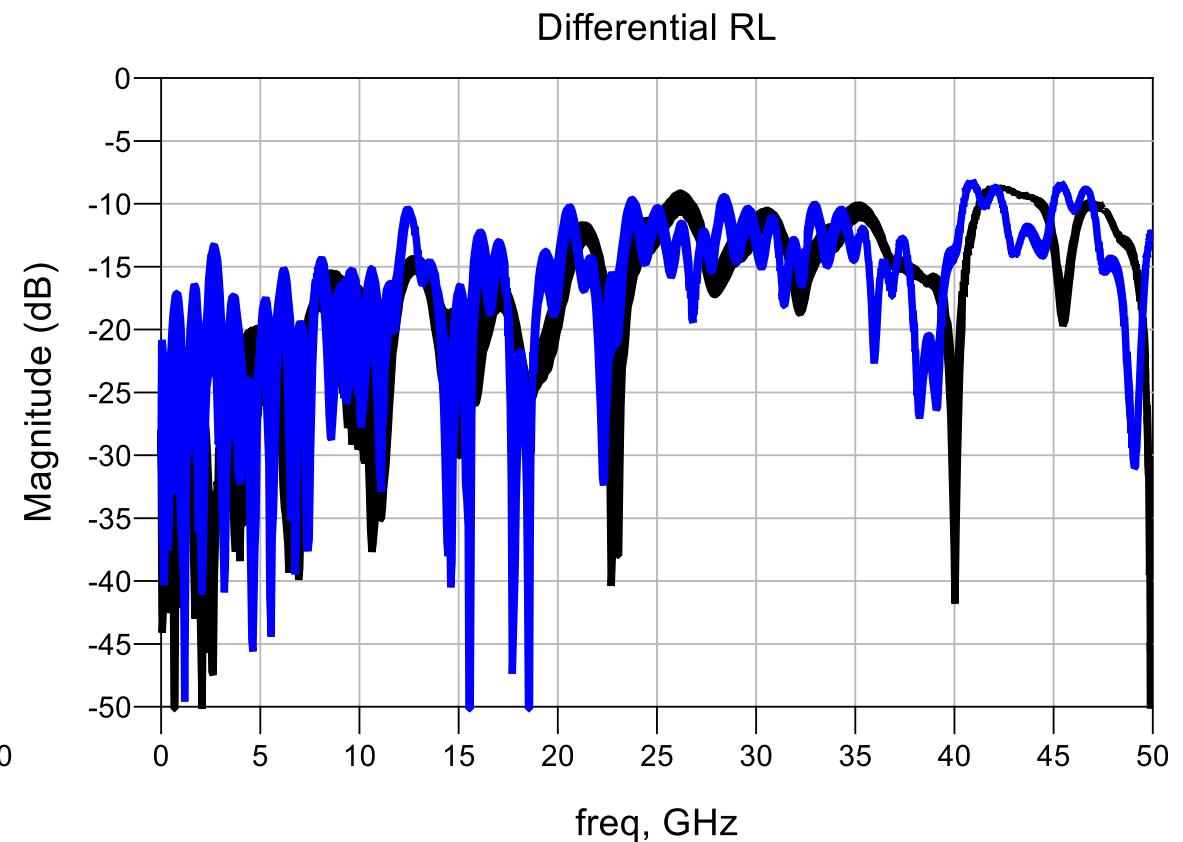
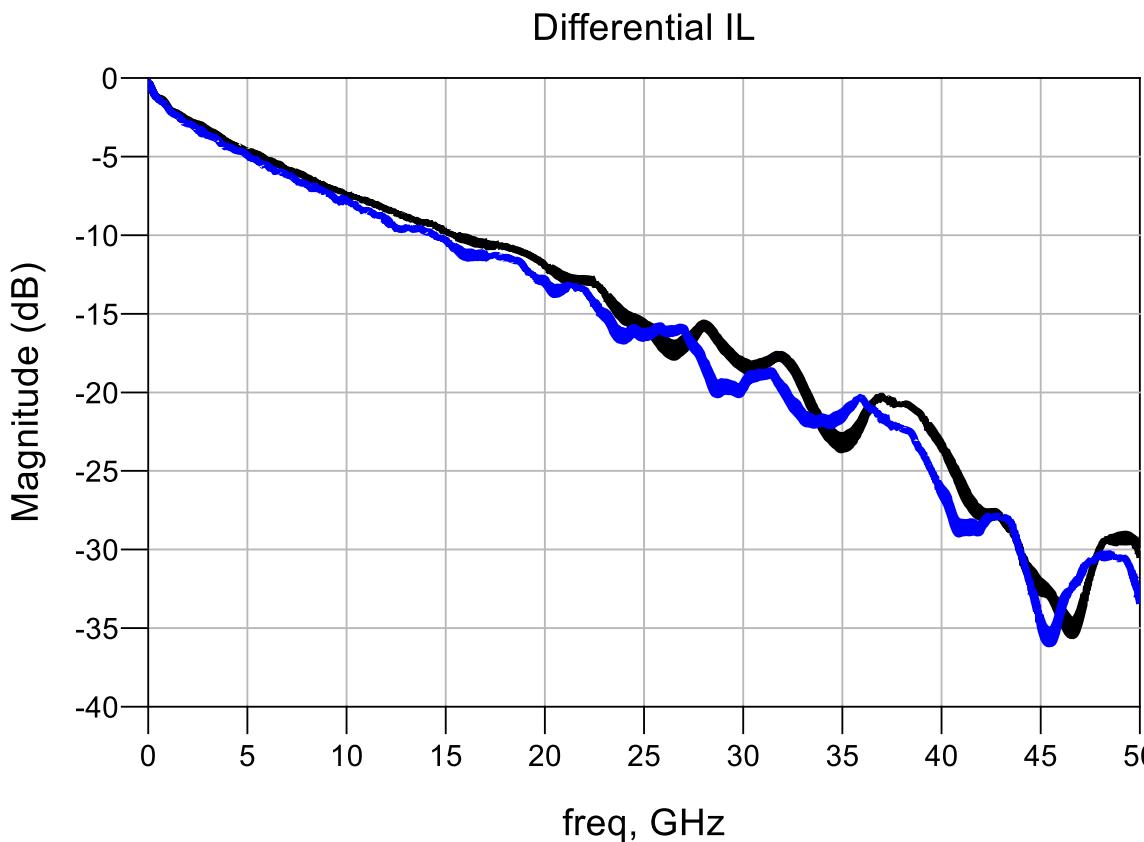


OSFP Conn,  
Module, &  
Cable  
Termination



# 17.6dB CR Channel comparison: 100 Ohm and 90 Ohm

Nominal simulation design hits 17.7dB @26.56GHz – There is no margin included in the simulation for manufacturing tolerances (cable/connector/PCB) which will impact IL variation



# COM v2.51 – CR OSFP Conn in 17.6dB Channel

15 Crosstalk Aggressors – 8 NEXT AND 7 FEXT  
Maximum Frequency = 50 GHz – 10MHz Step

COM script 2.51  
(FFE: 24 DFE)

	PAM-4 [IEEE802.3ck]	
COM*	Case 1	Case 2
<b>CR – OSFP 100 ohm</b>	<b>5.89</b>	<b>4.85</b>
<b>CR – OSFP 90 ohm</b>	<b>5.02</b>	<b>4.66</b>

- COM script version 2.51 (com\_ieee8023\_93a\_251a.m)
- Configuration settings (config\_com\_ieee8023\_93a=100GEL-CR\_DFE\_100118)
- COM > 3dB PASSES
- COM Test Case 1 and Test Case 2 differ in the value of the device package transmission line length  $z_p$  - 12mm and 30mm respectively

# Host + Cable Assembly Channel Simulation

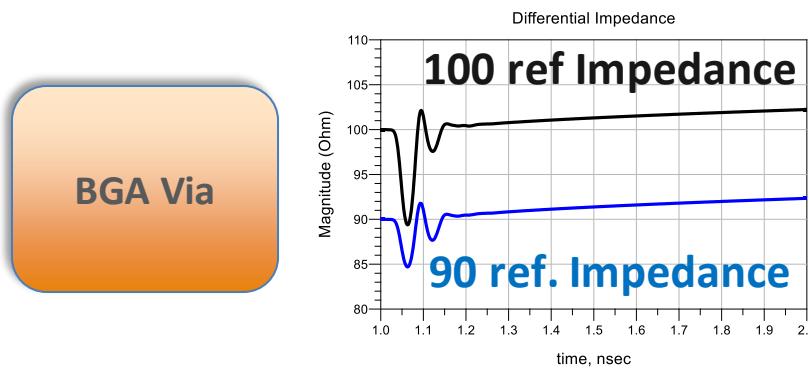
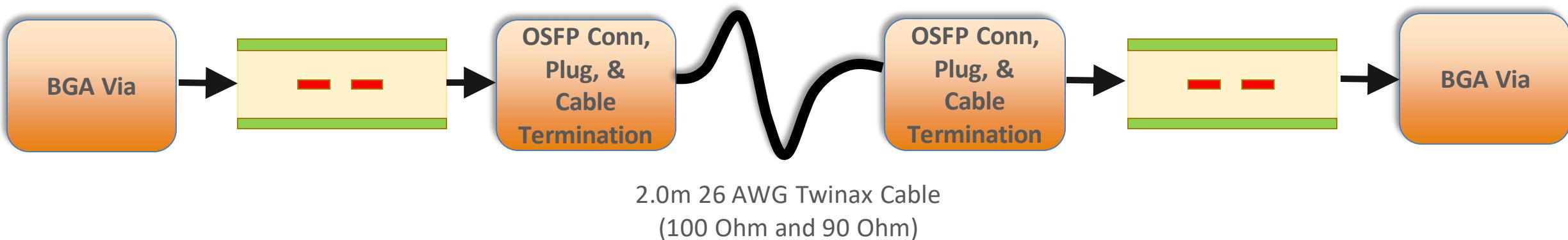
# 28dB Host/DAC Channel (TP0-TP5) - description

-6.54dB@26.56GHz – 100 ref. Impedance

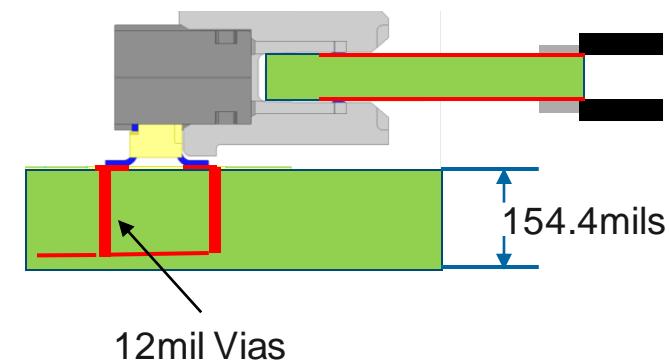
-6.76dB@26.56GHz – 90 ref. Impedance

-6.54dB@26.56GHz – 100 ref. Impedance

-6.76dB@26.56GHz – 90 ref. Impedance

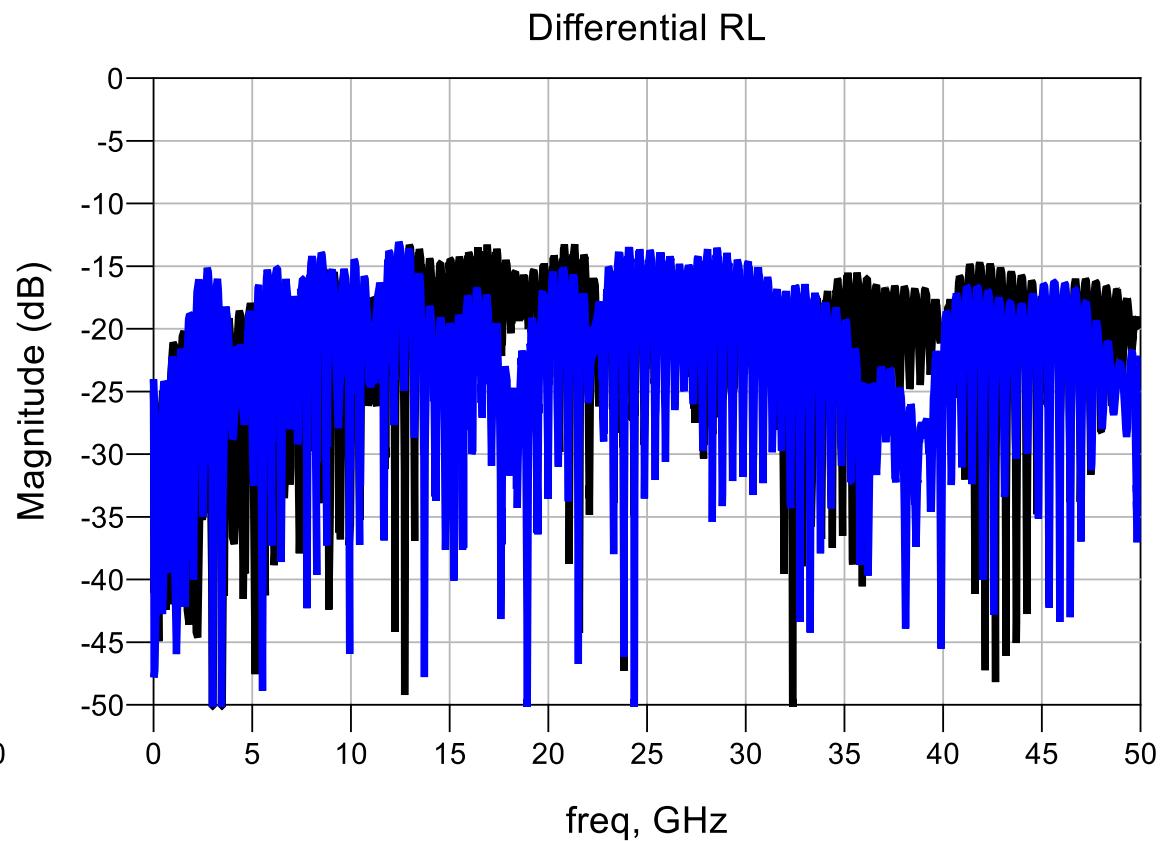
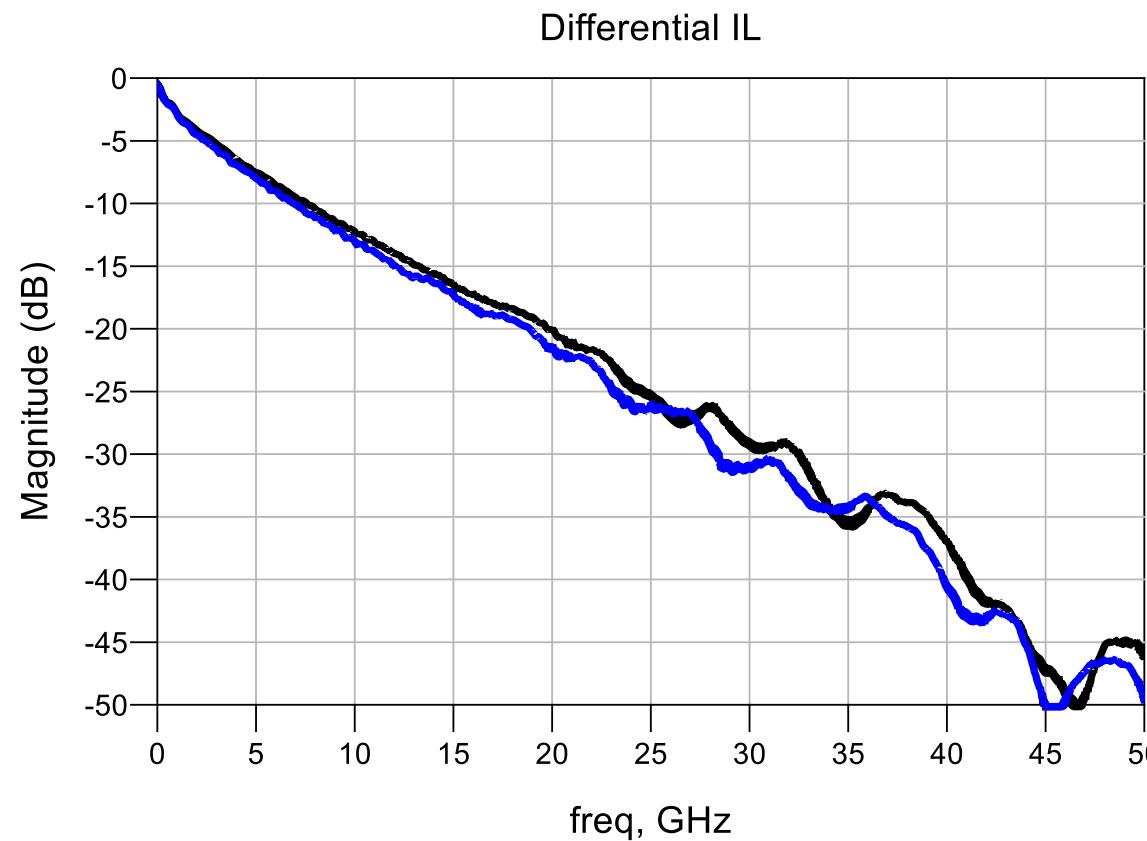


OSFP Conn,  
Plug, &  
Cable  
Termination



# 28.0dB CR Channel comparison: 100 Ohm and 90 Ohm

Nominal simulation design hits 17.7dB @26.56GHz – There is no margin included in the simulation for manufacturing tolerances (cable/connector/PCB) which will impact IL variation



# COM 2.51: 28db Direct Attach Cable on a Host

15 Crosstalk Aggressors – 8 NEXT AND 7 FEXT  
Maximum Frequency = 50 GHz – 10MHz Step

COM script 2.51  
(FFE: 24 DFE)

	PAM-4 [IEEE802.3ck]	
COM*	Case 1	Case 2
<b>28dB DAC – OSFP 100 ohm</b>	<b>5.44</b>	<b>4.61</b>
<b>28dB DAC – OSFP 90 ohm</b>	<b>5.09</b>	<b>4.04</b>

- COM script version 2.51 (com\_ieee8023\_93a\_251a.m)
- Configuration settings (config\_com\_ieee8023\_93a=100GEL-CR\_DFE\_100118)
- COM > 3dB PASSES
- COM Test Case 1 and Test Case 2 differ in the value of the device package transmission line length  $z_p$  - 12mm and 30mm respectively

Host PCB was not included in the spreadsheet,  
since it is already included in the simulation

# Summary

- 16dB Chip to Module channel has been modeled with both 100 and 90  $\Omega$  reference impedances traces
  - Promising results shown using COM 2.41
  - 100  $\Omega$  reference impedance provides better COM result by about ~0.3dB
- 17.6dB Direct Attach Copper cable channel simulated with both 100 and 90  $\Omega$  reference impedance traces/cable/connector (CR)
  - 100  $\Omega$  reference impedance provides better COM result by about ~0.8dB (Case1=12mm) and ~0.2dB (Case2=30mm)
  - Reported numbers are based on nominal Connector/Cable/PCB simulation design. Cable, connector and PCB manufacturing deviation is not considered in this study

## Summary - 2

- 100/90 $\Omega$  Thick Host + DAC + Thick Host
  - 100  $\Omega$  ref provides better COM result by about ~0.35dB, Case 1 & ~0.6dB, Case2
  - MCBs are normally constructed on thin stack-ups so that via loss is not included (microstrip trace is sometimes used)
    - The IL budget on Thick Host + Cable Assembly + Thick Host Channel should account for the 4 via/stub losses (2xBGA Via + 2x Connector Via, ~0.5dB/via at 28GHz)
    - Current IL budget does not account for these losses
  - Reported numbers are based on nominal Connector/Cable/PCB simulation design. Any cable, connector, and PCB manufacturing deviation is not considered in this study
  - Considering current proposed budgets/allocations and simulations, a budget higher than 28dB is likely to be required for cable assembly channels (2m)
- 100  $\Omega$  provides the best performance
  - Improved impedance match from 90  $\Omega$  reference is overcome by higher losses